

microscope objective / lens positioning system

MIPOS 20

- 20µm focusing range
- compact design
- high resonant frequency
- easy to mount on microscopes
- universal use by Flex-Adapter
- optionally feedback sensor

applications

Concept

- surface scanning and analysis
- AFM microscopy
- biotechnology (e.g. cell scanning)
- beam focusing for printing processes
- semiconductor test equipment

Specials

The systems of the MIPOS 20 series offer a nano positioning and scanning range up to 20μ m in open loop operation, as well as 16μ m in closed loop. They can be assembled with objectives that have a diameter of up to 35mm.

The successful parallelogram design of *piezosystem jena* guarantees high parallel motion without influencing the optical path.

The positioning repeatability can be guaranteed by an integrated measurement system.

The design with integrated preload of the actuator offers the following advantages:

- high resonant frequency
- highly parallel motion

Based on these features, fast scanning applications can be accurately realized with the shortest settling times. Adapter thread rings for the nose piece are available separately. They allow for fast mounting and exchanging of the MIPOS system on the microscope. Other objectives no longer need to be removed.

These Flex-Adapters are available for all standard microscopes, and allow the MIPOS 20 series to be universally applicable.

Parfocal tube extensions for each threading type are available as an accessory.



fig.: MIPOS 20

Mounting/Installation



1. Screw the objective into the MIPOS



2. Screw the Flex-Adapter into the microscope



3. Clamp the MIPOS on the Flex-Adapter using the attachment screw



Spacer rings to compensate the extended optical path are available and flex adapters for all common threads.





technical data:

series MIPOS		ur	it	MIPOS 20	MIPOS 20 SG
part no. for	M25x0.75	-		O-383-00	O-383-01
	W0.8x1/36" (I	RMS) -		O-384-00	0-384-01
	M26x0.75	-		O-385-00	0-385-01
thread	M27x0.75	-		O-386-00	O-386-01
axis		-			Z
motion open loop (±10%)*		μι	n	20	
motion closed loop (±0.2%)*		μι	n	-	16
capacitance (±20%)**		μ	F	0.7	
integrated measurement system		tem -		-	strain gage
resolution open loop***		nr	n	0.04	
resolution closed loop***		nr	n	-	1
typ. repeatability		nr	n	-	5
resonant frequency		н	z	950	
additional load = 80g		g H	z	520	
additional load = 105g		5g H	z	450	
additional load = 300g		Og H	z	240	
stiffness		N/µ	ım	4.0	
rotational error (full motion)		μra	ad	<5	
voltage range		<u>۱</u>	/	-20 +130	
connector***	** vol	tage -		LEMO 0S.302	
	ser	isor -		-	LEMO 0S.304
cable length		n	ı	1.0	1.2
min. bend radius of cable		m	m	>15	
material				stainless steel	
dimensions (l x w x h)		m	m	54 x 32 x 32.5	
weight		E E	5	95	115
max. lens diameter		m	m	35	
max. lens weight		g	5	300	
option for standard microscopes				yes	yes
option for inverse microscopes		es -		no	no

* typical value measured with NV 40/3 amplifier (closed loop: NV 40/3 CLE amplifier)

** typical value for small electrical field strength

*** The resolution is only limited by the noise of the power amplifier and metrology.

****in combination with a digital controller unit the system comes with a Sub-D 15 connector. The part number is extended by the suffix "D".

recommended configurations:

actuator	MIPOS 20 SG	O-383-01E
amplifier/controller	NV 40/1 CLE	E-101-73

The series of micro lens and objective positioning systems MIPOS offers a travel range from 20μ m up to 500μ m in z-axis. Available for standard and inverted microscopes More details under "z-axis-lens-positioning" <u>www.piezojena.com</u>.

Additional microscopy stages for XY axes available under "series-PXY-AP" www.piezojena.com

Rights reserved to change specifications as progress occurs without notice!